S	ea	rci	h M	Voi	tes	;	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/826,513	TAKADA, TOSHIYUKI
Examiner	Art Unit
Khiem Nguyen	2839

	SEAR	CHED	
Class	Subclass	Date	Examiner
То	Date	12/14/2005	KN
	·		
	,, .,,		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
See	Search			
Notes				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See East Interference Search History Printout	12/24/2005	KN		